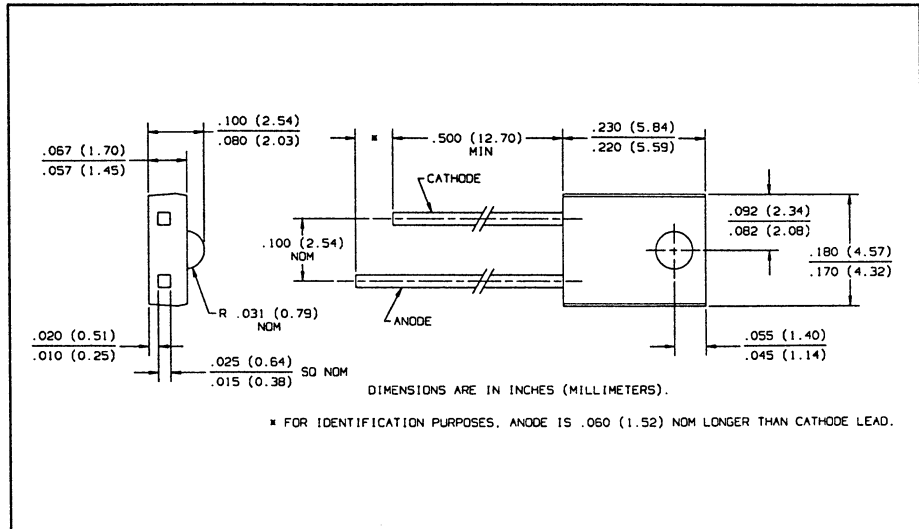
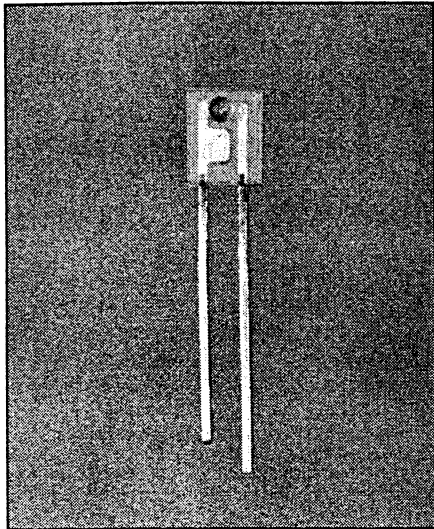


# GaAlAs Plastic Infrared Emitting Diodes

## Types OP240A, OP240B, OP240C, OP240D



### Features

- Wide irradiance pattern
- Mechanically and spectrally matched to the OP550 and OP560 series phototransistors
- Wavelength matched to silicon's peak response
- Significantly higher power output than GaAs at equivalent drive currents
- Side-looking package for space limited applications

### Description

The OP240 series devices are 890nm high intensity gallium aluminum arsenide infrared emitting diodes molded in IR transmissive clear epoxy packages. The side-looking packages are for use in PC board mounted slotted switches or as easily mounted interrupt detectors.

### Replaces

OP240SL series

### Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

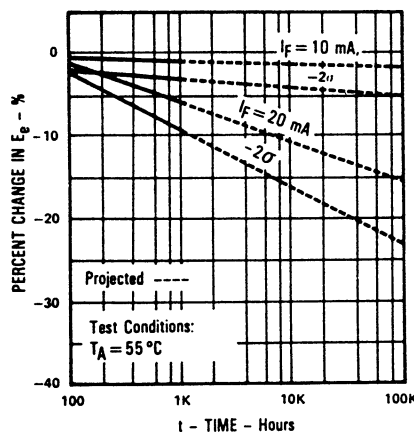
Reverse Voltage	2.0 V
Continuous Forward Current	50 mA
Peak Forward Current (1 $\mu\text{s}$ pulse width, 300 pps)	3.0 A
Storage and Operating Temperature Range	$-40^\circ\text{C}$ to $+100^\circ\text{C}$
Lead Soldering Temperature [1/16 inch (1.6 mm) from case for 5 sec. with soldering iron]	$260^\circ\text{C}^{(1)}$
Power Dissipation	$100\text{ mW}^{(2)}$

#### Notes:

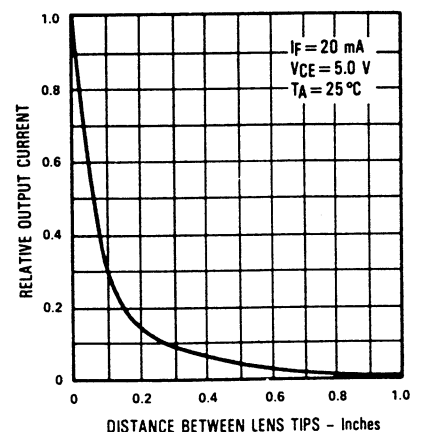
- (1) RMA flux is recommended. Duration can be extended to 10 sec. max. when flow soldering. A max. of 20 grams force may be applied to the leads when soldering.
- (2) Derate linearly  $1.33\text{ mW}/^\circ\text{C}$  above  $25^\circ\text{C}$ .
- (3)  $E_{e(\text{APT})}$  is a measurement of the average apertured radiant incidence upon a sensing area  $0.180"$  (4.57 mm) in diameter perpendicular to and centered on the mechanical axis of the lens and  $0.653"$  (16.6 mm) from the lens tip.  $E_{e(\text{APT})}$  is not necessarily uniform within the measured area.

### Typical Performance Curves

#### Percent Changes in Radiant Intensity vs Time



### Coupling Characteristics of OP240 and OP550



# Types OP240A, OP240B, OP240C, OP240D

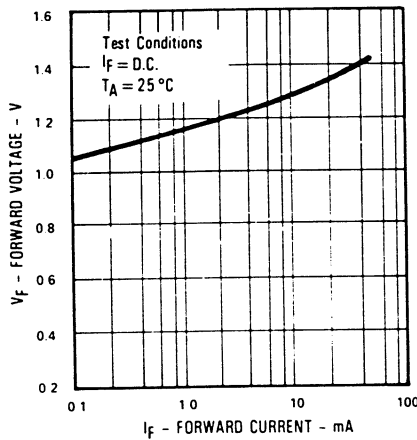
Electrical Characteristics ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS
$E_e(\text{APT})$	Apertured Radiant Incidence	OP240D 0.05 OP240C 0.20 OP240B 0.40 OP240A 0.60		0.86 1.20	$\text{mW}/\text{cm}^2$ $\text{mW}/\text{cm}^2$ $\text{mW}/\text{cm}^2$ $\text{mW}/\text{cm}^2$	$I_F = 20\text{ mA}^{(3)}$ $I_F = 20\text{ mA}^{(3)}$ $I_F = 20\text{ mA}^{(3)}$ $I_F = 20\text{ mA}^{(3)}$
$V_F$	Forward Voltage			1.80	V	$I_F = 20\text{ mA}$
$I_R$	Reverse Current			100	$\mu\text{A}$	$V_R = 2\text{ V}$
$\lambda_p$	Wavelength at Peak Emission		890		nm	$I_F = 10\text{ mA}$
B	Spectral Bandwidth Between Half Power Points		80		nm	$I_F = 10\text{ mA}$
$\Delta\lambda_p/\Delta T$	Spectral Shift with Temperature		+0.18		$\text{nm}/^\circ\text{C}$	$I_F = \text{Constant}$
$\theta_{\text{HP}}$	Emission Angle at Half Power Points		40		Deg.	$I_F = 20\text{ mA}$
$t_r$	Output Rise Time		500		ns	$I_{F(\text{PK})} = 100\text{ mA}$ , PW = 10 $\mu\text{s}$ , D.C. = 10%
$t_f$	Output Fall Time		250		ns	

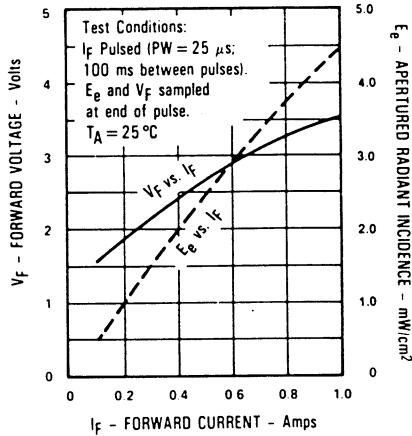
INFRARED  
EMITTING  
DIODES

## Typical Performance Curves

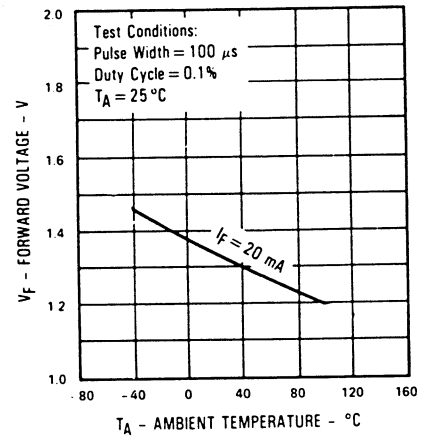
Forward Voltage vs Forward Current



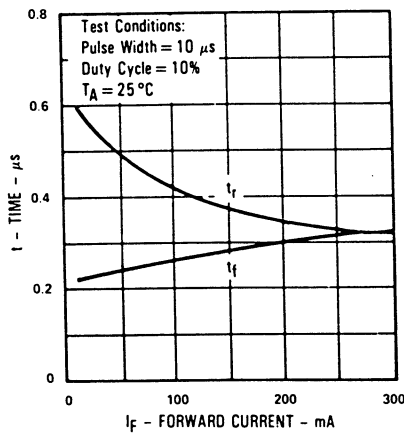
Forward Voltage and Radiant Incidence vs Forward Current



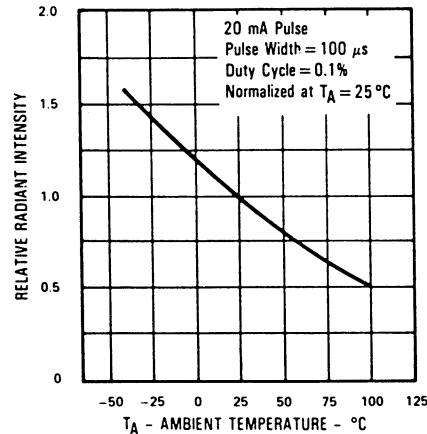
Forward Voltage vs Ambient Temperature



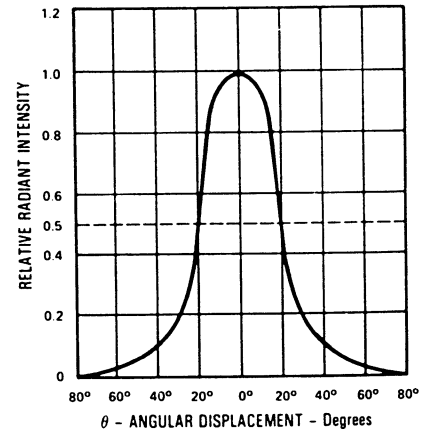
Rise Time and Fall Time vs Forward Current



Relative Radiant Intensity vs Ambient Temperature



Relative Radiant Intensity vs Angular Displacement



Optek reserves the right to make changes at any time in order to improve design and to supply the best product possible.

Optek Technology, Inc. 1215 W. Crosby Road Carrollton, Texas 75006 (972)323-2200 Fax (972)323-2396